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Application No.	Applicant(s)
10/050,552	NAGEM ET AL.
Examiner	Art Unit
Nashaat T. Nashed, Ph. D.	1652

SEARCHED			
Class	Subclass	Date	Examiner
530	350 351	7/7/2004	NASH
702	19 27	7/7/2004	NASH
536	23.1 23.5	7/7/2004	NASH
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
Sequence search of SEQ ID NO: 2 in commercial data bases, issued US patents, and PGPUB files.	7/2/2004	NASH	
STN search, enclosed.	7/7/2004	NASH	
WEST search, enclosed.	7/7/2004	NASH	
Discussed the claims with Primary Examiner Prima Mertz.	7/8/2004	NASH	